## Notice of References Cited Application/Control No. 10/766,591 Examiner CHRYSTINA ZELASKIEWICZ Applicant(s)/Patent Under Reexamination CHEN ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0050114	03-2003	Leen et al.	463/25
*	В	US-6,758,754	07-2004	Lavanchy et al.	463/42
*	С	US-7,086,947	08-2006	Walker et al.	463/25
*	D	US-6,468,155	10-2002	Zucker et al.	463/23
*	Е	US-2003/0163729	08-2003	Buchegger, Sonja	713/201
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	٦	US-			
	K	US-			
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## FOREIGN PATENT DOCUMENTS

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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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